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Information Disclosure Statement by Applicant		Wolfgang Babel et al.		Group					
		May 11, 2006			Unassigned				
		U.S. Pat	tent Documents						
Examiner Initial	Document Number	Date	Patentee/Applicant		Class Subclass			Filing Date if Appropriate	
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		Foreign P	atent Documents		т	· · · · ·			
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7VN/	WO 94/06005	17/Mar/94	WIPO				165	-10	
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/VN/	I-Yu Huang et al., "Improvement of Integrated Ag/AgCl Thin-Film Electrodes by KC1-Gel Coating for ISFET Applications", 2003, Elsevier Science B.V.								
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EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; Draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date Considered

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